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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









Benefits

- Advanced Process Technology
- Surface Mount (IRF9530NS)
- Low-profile through-hole(IRF9530NL)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead-Free

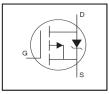
Description

Fifth Generation HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

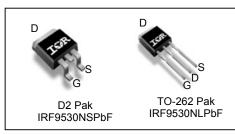
The D2Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D2Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF9530NL) is available for low-profile applications.

HEXFET® Power MOSFET



$V_{ t DSS}$	-100V
R _{DS(on)}	0.20Ω
I_D	-14A



G	D	S
Gate	Drain	Source

Base next number Baskens Tun		Standard Pack	Orderable Bort Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number
IRF9530NLPbF	TO-262	Tube	50	IRF9530NLPbF (Obsolete)
IRF9530NSPbF	D2-Pak	Tape and Reel Left	800	IRF9530NSTRLPbF

Absolute Maximum Ratings					
Symbol	Parameter	Max.	Units		
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V S	-14			
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V S	-10	A		
I _{DM}	Pulsed Drain Current ①⑤	-56			
P _D @T _A = 25°C	Maximum Power Dissipation	3.8	W		
P _D @T _C = 25°C	Maximum Power Dissipation	79	W		
	Linear Derating Factor	0.53	W/°C		
V_{GS}	Gate-to-Source Voltage	± 20	V		
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②⑤	250	mJ		
I _{AR}	Avalanche Current ①	-8.4	Α		
E _{AR}	Repetitive Avalanche Energy ①	7.9	mJ		
dv/dt	Peak Diode Recovery dv/dt@⑤	-5.0	V/ns		
T _J	Operating Junction and	-55 to + 175			
T_{STG}	Storage Temperature Range		°C		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300			
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		1.9	°C /\\/
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state) ©		40	°C/W



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.11		V/°C	Reference to 25°C, I _D = -1mA ©
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.20	Ω	$V_{GS} = -10V, I_D = -8.4A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
gfs	Forward Trans conductance	3.2			S	$V_{DS} = -50V, I_{D} = -8.4A$ (S)
I	Drain-to-Source Leakage Current			-25	μA	$V_{DS} = -100V, V_{GS} = 0V$
I _{DSS}	Diain-to-Source Leakage Current			-250	μΛ	$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			-100	nA	$V_{GS} = -20V$
I _{GSS}	Gate-to-Source Reverse Leakage			100	IIA	$V_{GS} = 20V$
Q_g	Total Gate Charge			58		$I_D = -8.4A$
Q_{gs}	Gate-to-Source Charge			8.3	nC	$V_{DS} = -80V$
Q_{qd}	Gate-to-Drain Charge			32		V _{GS} = -10V See Fig.6 and 13 ④ ⑤
$\mathbf{t}_{d(on)}$	Turn-On Delay Time		15			$V_{DD} = -50V$
t _r	Rise Time		58			$I_{D} = -8.4A$
$t_{d(off)}$	Turn-Off Delay Time		45		ns	$R_G = 9.1\Omega$
t _f	Fall Time		46			R _D = 6.2Ω See Fig.6 ④⑤
L _S	Internal Source Inductance		7.5			Between lead, and center of die contact
C _{iss}	Input Capacitance		760			$V_{GS} = 0V$
C _{oss}	Output Capacitance		260		рF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		170			f = 1.0MHz, See Fig. 5 ⑤

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			-14	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			-56		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -8.4A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		130	190	ns	$T_J = 25^{\circ}C$, $I_F = -8.4A$
Q_{rr}	Reverse Recovery Charge		650	970	nC	di/dt = -100A/µs ⊕⑤
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligib	le (turn-on is dominated by L _S +L _D)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\odot~$ starting $~T_J$ = 25°C, L = 7.0mH, R_G = 25 $\Omega,~I_{AS}$ = -8.4A. (See fig. 12)
- $\label{eq:loss_loss} \text{ $I_{SD} \leq -8.4A$, $di/dt \leq -490A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^{\circ}C$. }$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- © Uses IRF9530N data and test conditions.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

2016-5-27



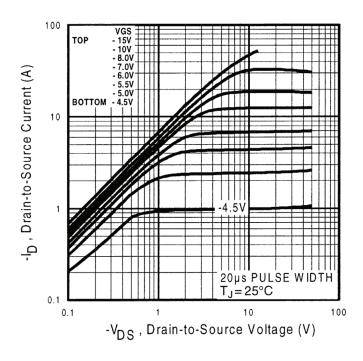


Fig. 1 Typical Output Characteristics

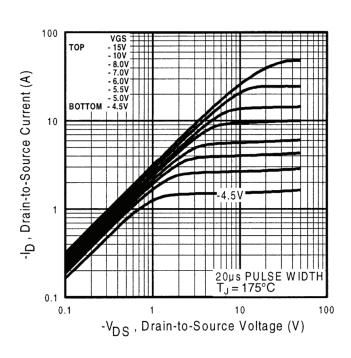


Fig. 2 Typical Output Characteristics

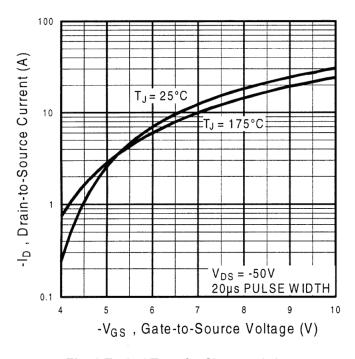


Fig. 3 Typical Transfer Characteristics

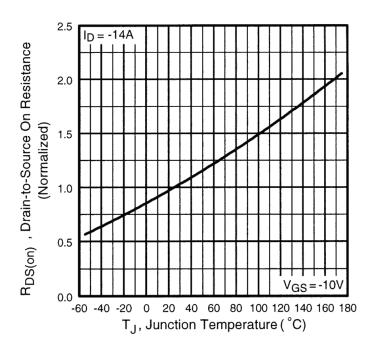


Fig. 4 Normalized On-Resistance vs. Temperature

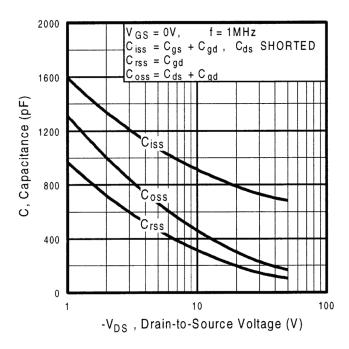


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

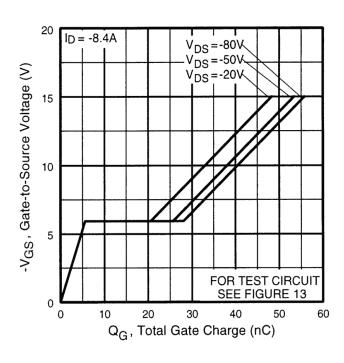


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

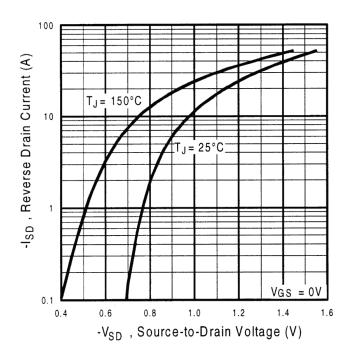


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

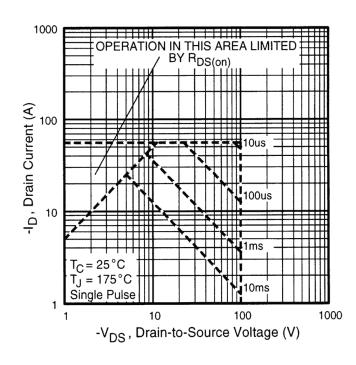


Fig 8. Maximum Safe Operating Area

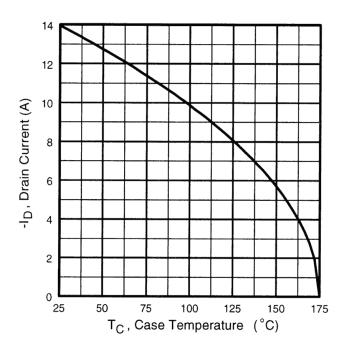


Fig 9. Maximum Drain Current vs. Case Temperature

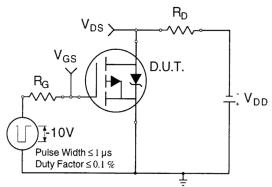


Fig 10a. Switching Time Test Circuit

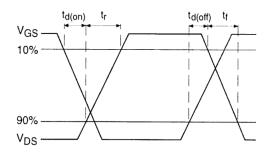


Fig 10b. Switching Time Waveforms

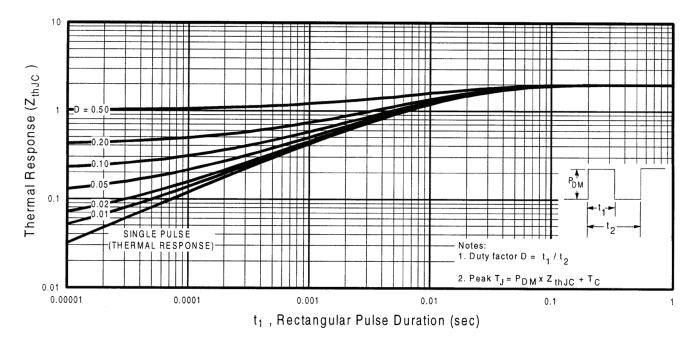


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



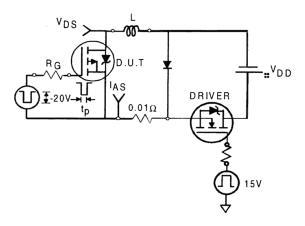


Fig 12a. Unclamped Inductive Test Circuit

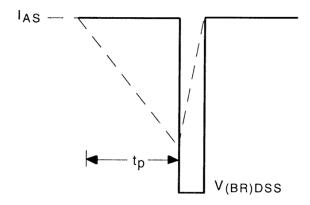


Fig 12b. Unclamped Inductive Waveforms

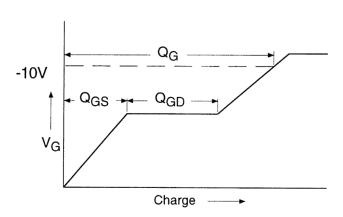


Fig 13a. Gate Charge Waveform

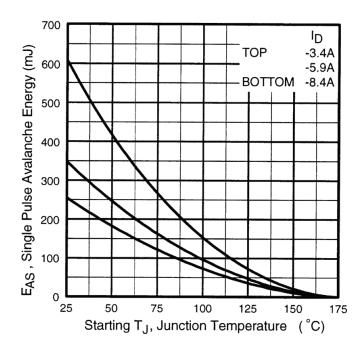


Fig 12c. Maximum Avalanche Energy vs. Drain Current

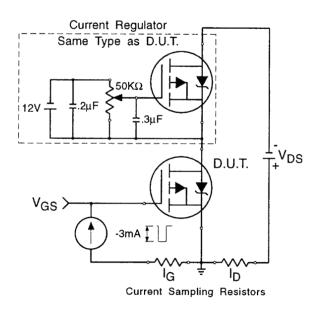
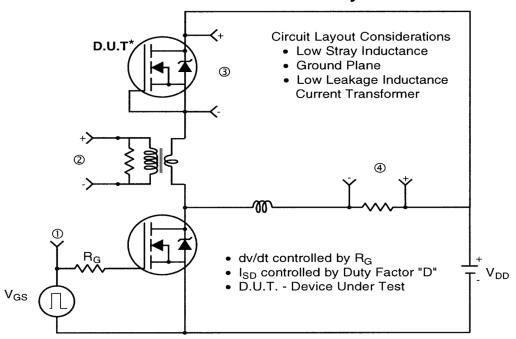


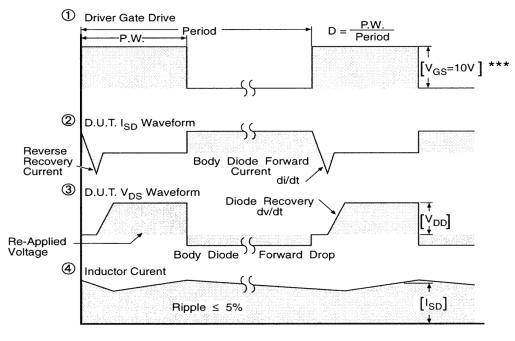
Fig 13b. Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel

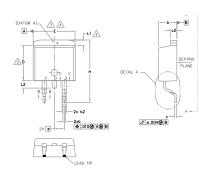


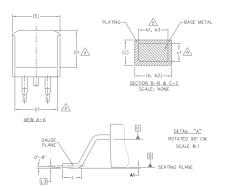
*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for PChannel HEXFET® Power MOSFETs



D2-Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M	DIMENSIONS					
В	MILLIM	ETERS	INC	HES	0 T E S	
O L	MIN.	MAX.	MIN.	MAX.	S	
А	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
Ь	0.51	0.99	.020	.039		
Ь1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
с1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	_	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245	_	4	
е	2.54	BSC	.100	.100 BSC		
Н	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	_	1.68	_	.066	4	
L2	_	1.78	_	.070		
L3	0.25	BSC	.010	BSC		

LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)

2, 4.- CATHODE 3.- ANODE

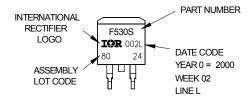
IGBTs, CoPACK 2, 4.- COLLECTOR 3.- EMITTER

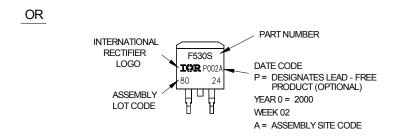
D2-Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024 ASSEMBLED ON WW 02, 2000

IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead - Free"



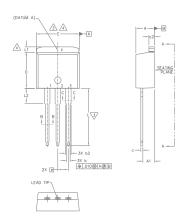


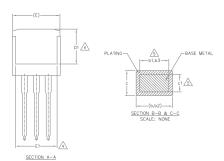
Note: For the most current drawing please refer to Infineon's web site www.infineon.com

2016-5-27



TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND 61 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.— OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(mox.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

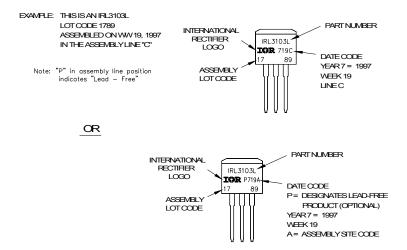
4.- COLLECTOR <u>HEXFET</u>

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

2.- DRAIN 3.- SOURCE 4.- DRAIN

S Y M						
В	MILLIM	ETERS	INC	INCHES		
0 L	MIN.	MAX.	MIN.	MAX.	O T E S	
А	4.06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
ь3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	_	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245		4	
е	2.54	BSC	.100 BSC			
L	13.46	14.10	.530	.555		
L1	_	1.65	_	.065	4	
L2	3.56	3.71	.140	.146		

TO-262 Part Marking Information

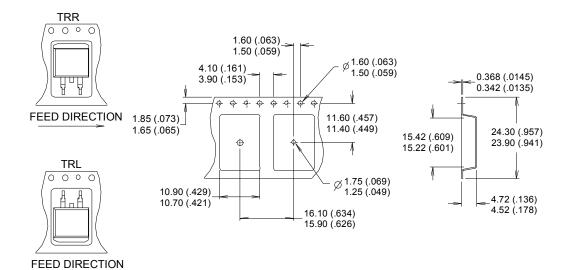


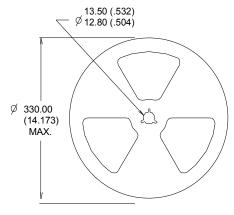
Note: For the most current drawing please refer to Infineon's web site www.infineon.com

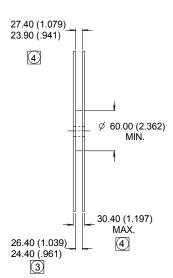
2016-5-27



D2-Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3. DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to Infineon's web site www.infineon.com



Qualification Information[†]

Qualification Level	Industrial (per JEDEC JESD47F) ††				
Moisture Sensitivity Level	D2-Pak	MSL1 (per JEDEC J-STD-020D) ^{††}			
	TO-262	N/A			
RoHS Compliant	Yes				

- † Qualification standards can be found at Infineon's web site www.infineon.com
- †† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments
5/27/2016	 Updated datasheet with corporate template. Added disclaimer on last page.
	TO-262 package was removed from ordering information since it is EOL on page 1.

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Document reference ifx1

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